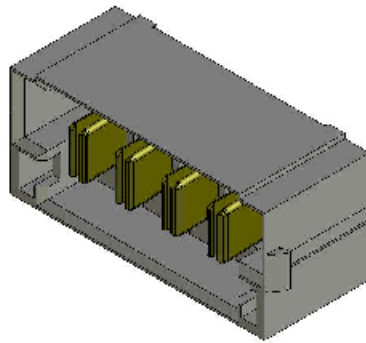
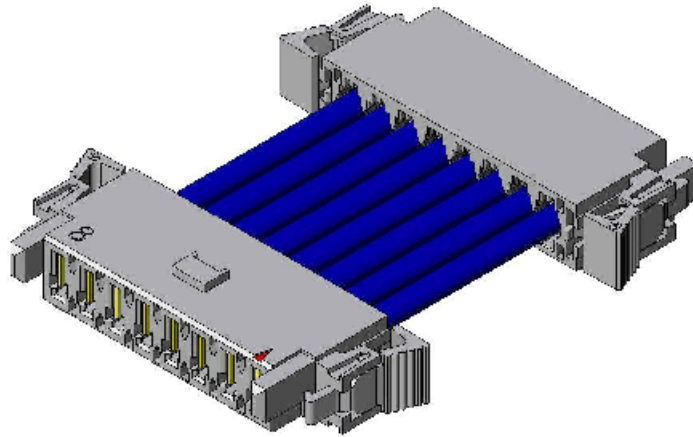




Project Number: 193139		Tracking Code: 193139	
Requested by: Eric Mings		Date: 9/4/2012	Product Rev: E
Part #: MPSS-08-16-L-12.00-DR-NUS		Lot #:	Tech: Tony Wagoner Eng: Eric Mings
Part Description: Mini Power Discrete Wire			Qty to test: 23
Test Start: 7/9/2012	Test Completed: 8/17/2012		

# **SAMTEC POWER CHARACTERIZATION**



**Mini Power Discrete Wire**  
**MPSS-08-16-L-12.00-DR-NUS**  
**MPT-08-6.30-01-L-V**

## CERTIFICATION

All instruments and measuring equipment were calibrated to National Institute for Standards and Technology (NIST) traceable standards according to ISO 10012-1 and ANSI/NCSL 2540-1, as applicable.

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### SCOPE

1. Temperature Rise/Current Carrying Capacity
  - 1.1. To determine the amount of current the device under test (DUT) can safely carry over the operating temperature range of the DUT.
  - 1.2. Contact loading will also be addressed in this document which will determine how much current can be carried as the number of energized contacts is varied.
2. Current Cycling
  - 2.1. To determine the performance of the device under test (DUT) when subjected to the power-on/power-off cycling that heats and cools the DUT in normal everyday use.
  - 2.2. Contact loading will set to 100% throughout the test.

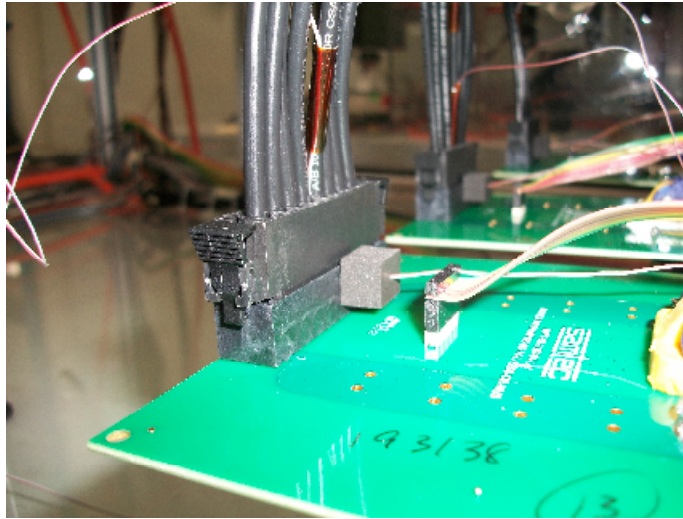
### APPLICABLE DOCUMENTS

Standards: EIA Publication 364-70 Temperature Rise  
EIA Publication 364-06 Contact Resistance  
EIA Publication 364-55 Current Cycling  
TLPM-032 Current Carrying Capacity  
TLPM-084 Current Cycling  
IEC 512-3 Electromechanical Components for Electronic Equipment: Basic Testing Procedures and Measuring Methods, Part 3: Current Carrying Capacity Tests

### TEST SAMPLES AND PREPARATION

1. All materials shall be manufactured in accordance with the applicable product specification.
2. All test samples shall be identified and encoded to maintain traceability throughout the test sequences.
3. After soldering, the parts to be used shall be cleaned according to TLWI-0001.
4. All samples shall be visually inspected and cleaned as necessary.
5. Any additional preparation shall be noted in the individual test sequences.
6. Solder Information: Lead Free
7. Re-Flow Time/Temp: See accompanying profile.
8. All products designed to operate mounted on a printed circuits board shall be tested mounted to test boards in accordance with EIA-364-70.

PREPARED TEST SAMPLE

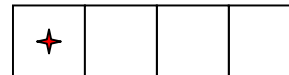


9. The following loading configurations shall be tested for Temperature Rise/Current Carrying Capacity testing of single row connector systems:
- 9.1. One contact energized only
  - 9.2. Two contacts energized adjacent to each other
  - 9.3. Three contacts energized adjacent to each other
  - 9.4. Four contacts energized adjacent to each other
  - 9.5. All contacts energized

✦ Indicates energized contacts

✦ Indicates thermocouple monitored, energized contacts

Test Condition as in 9.1 above



10. For Current Cycling, only 100 % loading will be tested.



# POWER INTEGRITY TEST REPORT

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INITIAL RELEASE

## FLOWCHARTS

### Current Carrying Capacity

3 Mated Assemblies Each

TEST STEP	GROUP A 3 Mated Assemblies 1 CONTACT POWERED	GROUP B 3 Mated Assemblies 2 CONTACTS POWERED	GROUP C 3 Mated Assemblies 3 CONTACTS POWERED	GROUP D 3 Mated Assemblies 4 CONTACTS POWERED	GROUP E 3 Mated Assemblies ALL CONTACTS POWERED
01	CCC	CCC	CCC	CCC	CCC

(TIN PLATING) - Tabulate calculated current at RT, 65° C, 75° C and 95° C after derating 20% and based on 105° C

(GOLD PLATING) - Tabulate calculated current at RT, 85° C, 95° C and 115° C after derating 20% and based on 105° C

CCC, Temp rise = EIA-364-70

### Current Cycling

TEST STEP	GROUP A 8 Mated Assemblies ALL CONTACTS POWERED
01	Current Cycle, 500 cycles at 125% of Rated current

Current Cycle = EIA 364-55, Condition "B", Method #4

Test at Current 125% of Rated Current

Measure at 45 minutes into ON time of cycle

Measure Voltage Drop on 5 random contacts



# POWER INTEGRITY TEST REPORT

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## TEST PROCEDURES

<b>Part No.</b>	MPSS-08-16-L-12.00-DR-NUS	<b>Mating Part No.</b>	MPT-08-6.30-01-L-V
<b>Sample Size</b>	15	<b>Technician</b>	Tony Wagoner
<b>Start Date</b>	7/9/2012	<b>Complete Date</b>	7/11/2012
<b>Room Ambient</b>	22°C	<b>Relative Humidity</b>	50%
<b>Equipment ID#: MO-04, PS-09, RS-01 TC111307-(018,013,009,047,048,040,042,043,050,012,0010,016,005,006)</b>			

### TEMPERATURE RISE (Current Carrying Capacity, CCC):

11. Thermocouples shall be calibrated in accordance with Samtec documents; TLWI 0003, Thermocouple Welding Procedure and TLWI 0005, Thermocouple Calibration
12. The thermocouples shall be placed at a location to sense the maximum temperature generated during testing.
13. Temperature stability shall be defined as the temperature at which three successive readings, 5 minutes apart, differ not more than 1° C (computer controlled data acquisition). This is the Temperature Rise that the Current Carrying Capacity and De-rating curves are based on.
14. The following loading configurations shall be tested (double for two row systems):
  - 14.1. One contact energized only
  - 14.2. Two contacts energized adjacent to each other
  - 14.3. Three contacts energized adjacent to each other
  - 14.4. Four contacts energized adjacent to each other
  - 14.5. All contacts energized
15. The following loading configurations shall be tested for Temperature Rise/Current Carrying Capacity testing of two row connector systems:
  - 15.1. Two by One contact energized
  - 15.2. Two by Two contacts energized adjacent to each other
  - 15.3. Two by Three contacts energized adjacent to each other
  - 15.4. Two by Four contacts energized adjacent to each other
  - 15.5. All contacts energized
16. Three samples shall be tested for each of the above configurations for a total of eighteen assemblies.
17. Temperature Rise measurements shall be made at 5 different current levels yielding temperature rises in the 10 to 70°C range.
18. The base curve for the Current Rating chart will be derived from the average (maximum) value of three test specimens in accordance with IEC 512-3, Test 5b.



**POWER INTEGRITY TEST  
REPORT**

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<b>Part No.</b>	MPSS-08-16-L-12.00-DR-NUS	<b>Mating Part No.</b>	MPT-08-6.30-01-L-V
<b>Sample Size</b>	8	<b>Technician</b>	Tony Wagoner
<b>Start Date</b>	7/27/2012	<b>Complete Date</b>	8/17/2012
<b>Room Ambient</b>	22°C	<b>Relative Humidity</b>	48%
<b>Equipment ID#: MO-10, PS-04, RS-04, TC111307-(020,019,021,017,014,016,012,008,027)</b>			

**CURRENT CYCLING**

1. Samples shall be prepared and tested as above (paragraph 14.5).
2. Current Cycling shall be performed in accordance with EIA-364-55, Test Condition
3. Testing shall be as follows:
  - 3.1. Test Current: **TEST CURRENT**(125% of 30°C Rating)
  - 3.2. "ON" Time: 45 Minutes
  - 3.3. "OFF" Time: 15 Minutes
  - 3.4. Number of Cycles: 500
  - 3.5. Measurements: 40 minutes into ON cycle
    - 3.5.1. Temperature
    - 3.5.2. Voltage Drop/Contact Resistance
4. Temperature vs. Number of Cycles and Voltage Drop vs. Number of Cycles shall be measured and recorded.

**TEST RESULTS**

**CURRENT CARRYING CAPACITY (CCC) RESULTS**

- There was no evidence of physical damage to the test samples as tested.
- The following is a summary of the observed data:

**Temperature Rise, CCC at a 20% de-rating**

- CCC for a 30°C Temperature Rise----- 15.9A per contact with 1 contact (1 x 1) powered
- CCC for a 30°C Temperature Rise----- 14.3A per contact with 2 contacts (1 x 2) powered
- CCC for a 30°C Temperature Rise----- 13.0A per contact with 3 contacts (1 x 3) powered
- CCC for a 30°C Temperature Rise----- 12.9A per contact with 4 contacts (1 x 4) powered
- CCC for a 30°C Temperature Rise----- 11.0A per contact with 8 contacts (1 x 8) powered

**CURRENT CYCLING RESULTS**

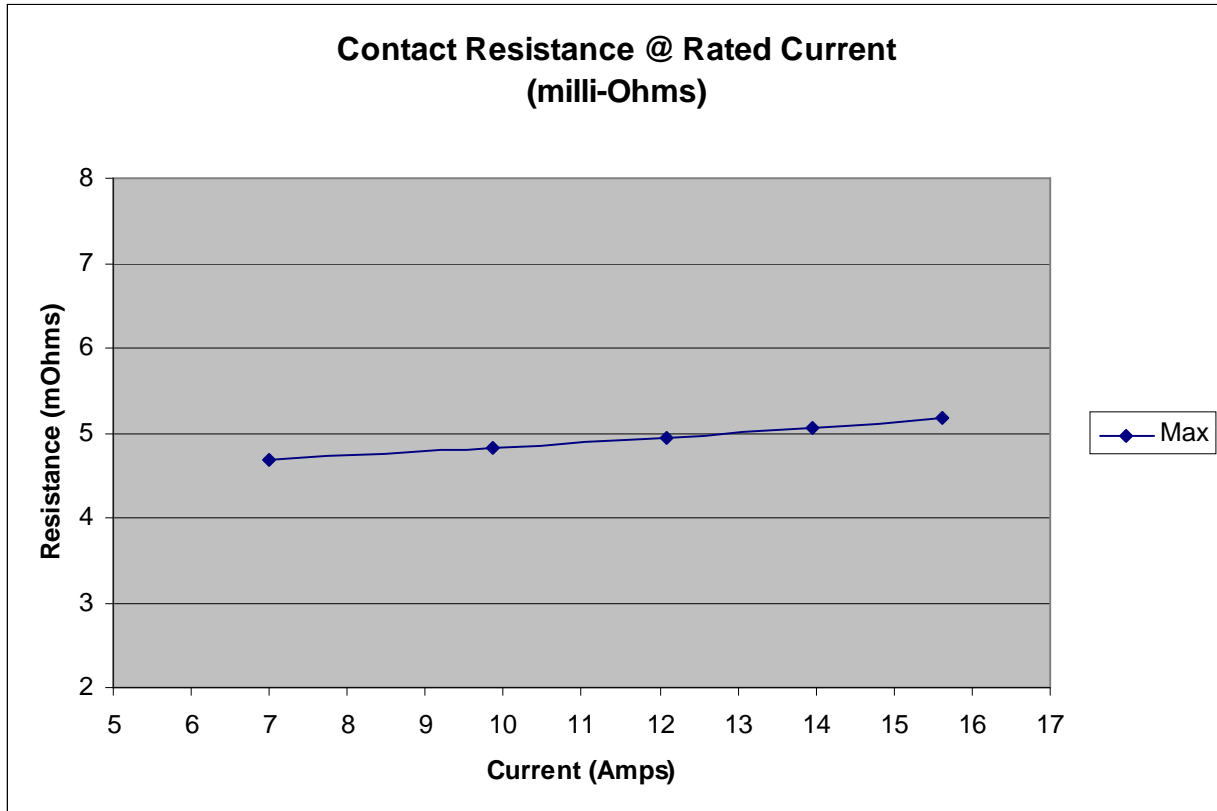
**Test Condition: 500 Cycles, 45 minutes ON and 15 minutes OFF**

- Test Current ----- 13.7 Amps
- Contact Resistances, Measured 40 minutes into the FIRST and LAST ON cycle
  - Initial
    - Min ----- 4.45 mOhms
    - Max ----- 4.69 mOhms
  - Final
    - Min ----- 5.02 mOhms
    - Max ----- 5.18 mOhms
- Temperature Change, Measured 40 minutes into the FIRST and LAST ON cycle
  - Initial Temperature Change ----- 26.7°C
  - Final Temperature Change ----- 26.0°C

**TEST DATA**

**CONTACT RESISTANCE @ RATED CURRENT - DC Resistance (DCR)**

The following data represents the Voltage drop and Contact Resistance at Rated Current for the 100% energized samples:



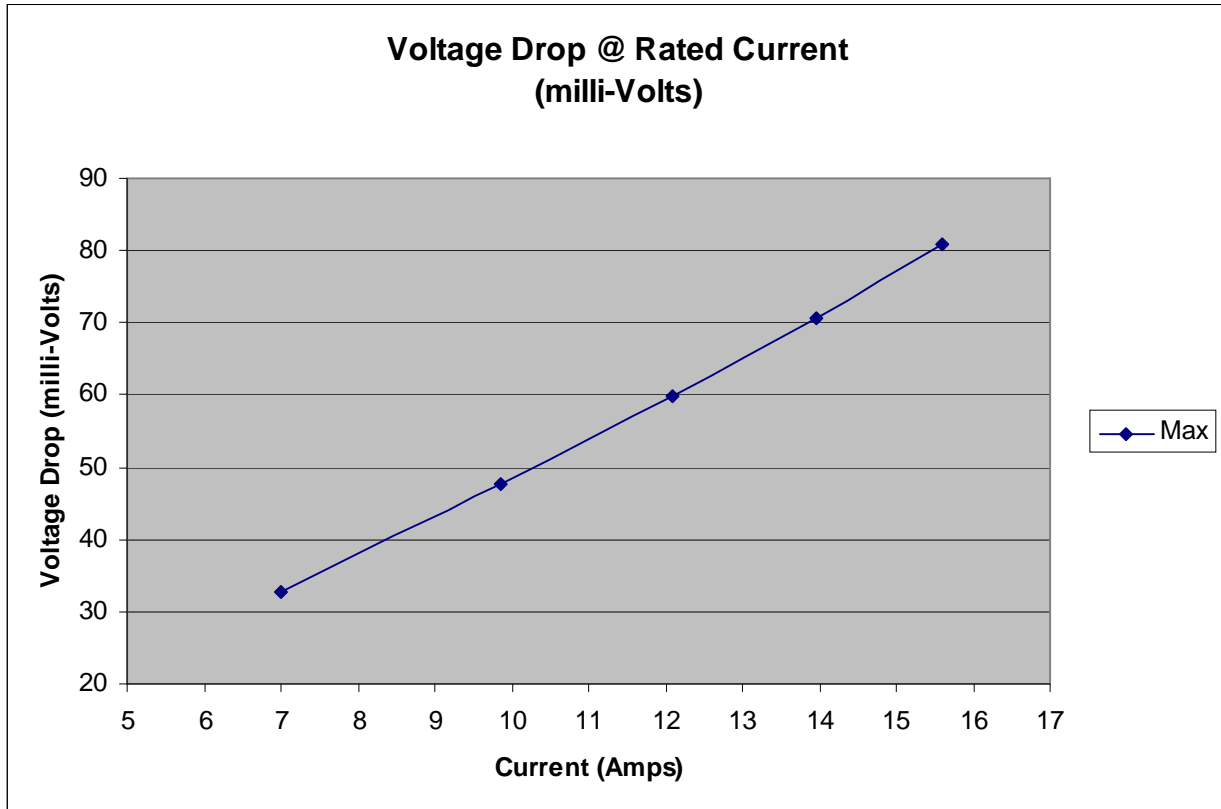
**CONTACT RESISTANCE DATA  
ALL CONTACTS ENERGIZED  
(mΩ)**

TEST CURRENT AMPS	6.99	9.86	12.09	13.96	15.61
Min	4.45	4.66	4.79	4.91	5.02
Max	4.69	4.82	4.94	5.07	5.18
Avg	4.61	4.73	4.85	4.97	5.09

**TEST DATA**

**VOLTAGE DROP @ RATED CURRENT**

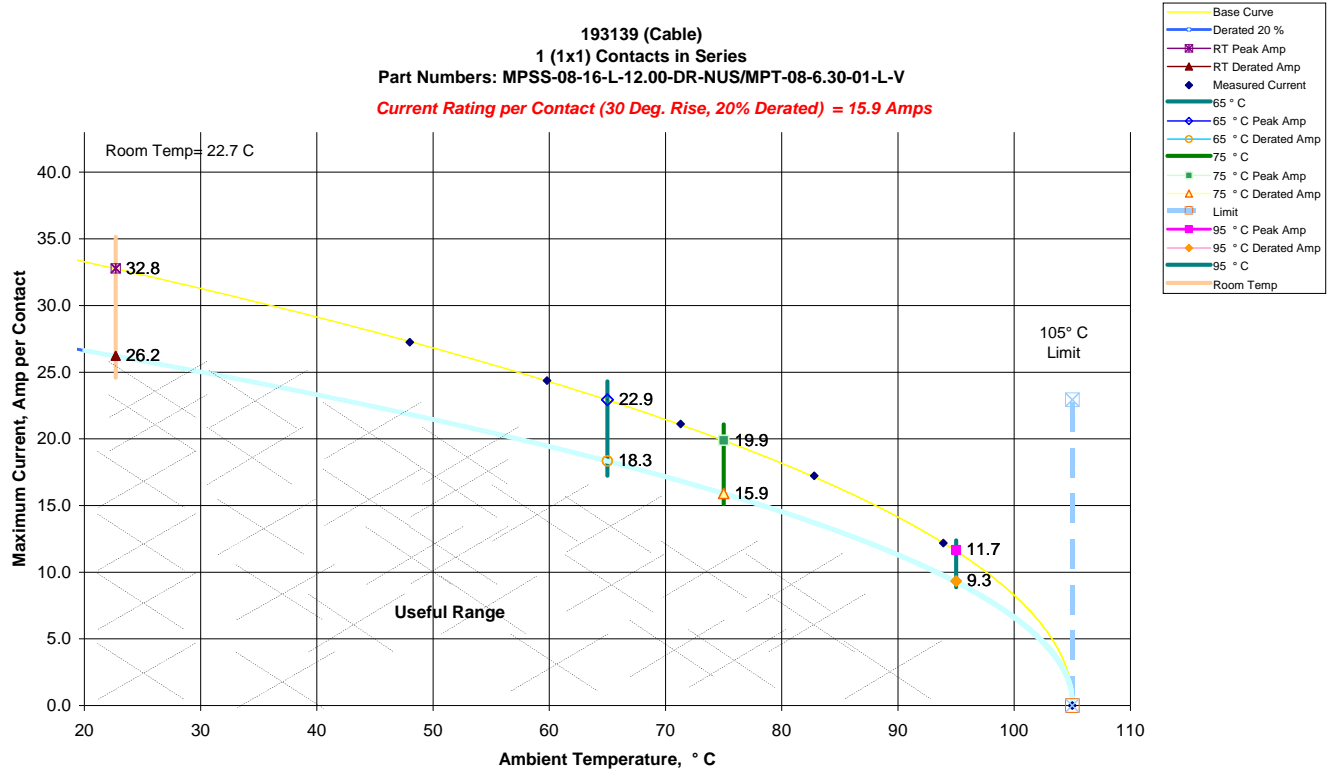
The following data represents the Voltage drop at Rated Current for the 100% energized samples:



**VOLTAGE DROP DATA  
ALL CONTACTS ENERGIZED  
(mV)**

TEST CURRENT AMPS	6.99	9.86	12.09	13.96	15.61
Min	31.09	45.97	57.94	68.56	78.36
Max	32.79	47.54	59.76	70.72	80.92
Avg	32.22	46.68	58.75	69.55	79.65

### CURRENT CARRYING CAPACITY DATA



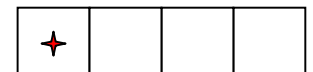
### TEMPERATURE RISE DATA ONE CONTACT ENERGIZED (Degrees Celsius above ambient)

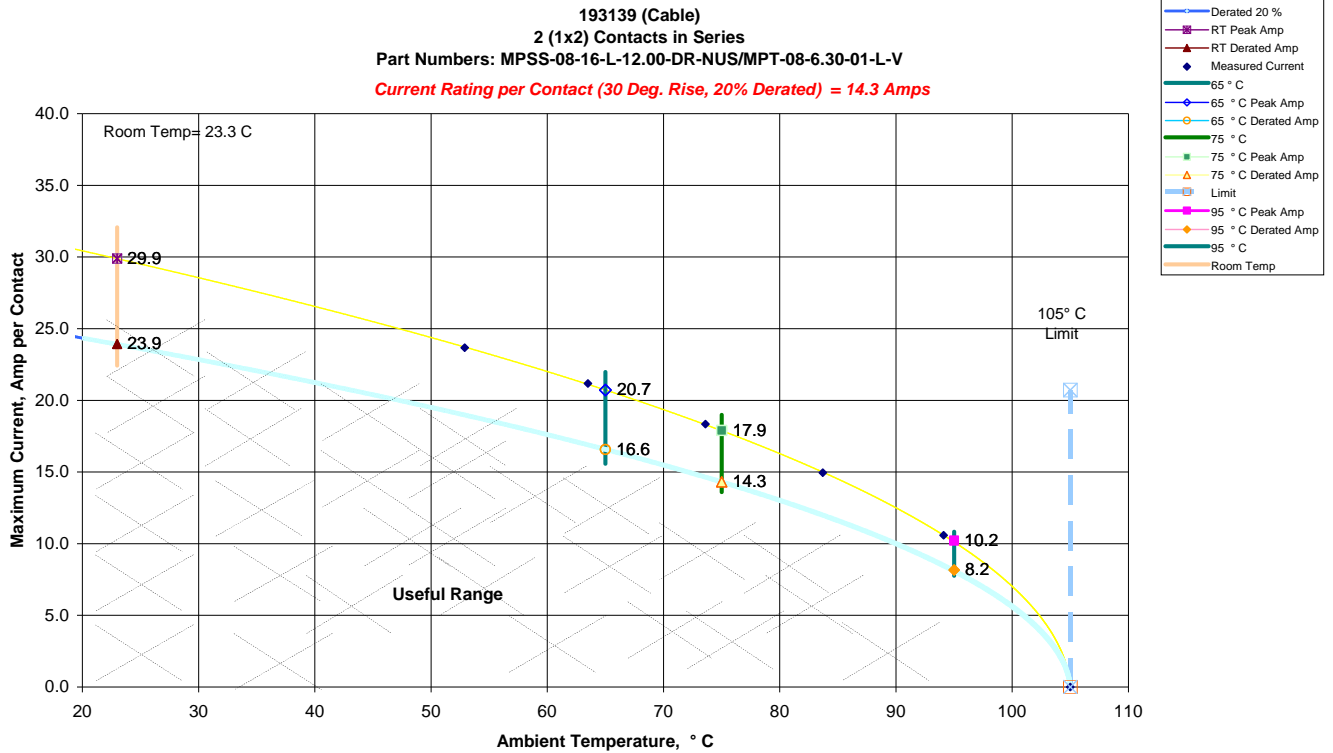
TEST CURRENT AMPS	12.19	17.22	21.11	24.37	27.25
Sample 1	11.5	23.1	35	46.9	59.3
Sample 2	10.8	21.5	32.5	43.3	54.4
Sample 3	11.1	22.1	33.6	45.4	57.2
Min	10.8	21.5	32.5	43.3	54.4
Max	11.5	23.1	35	46.9	59.3
Avg	11.13	22.23	33.7	45.2	56.97

Single Row Configuration

✦ Indicates energized contacts

✦ Indicates thermocouple monitored, energized contacts





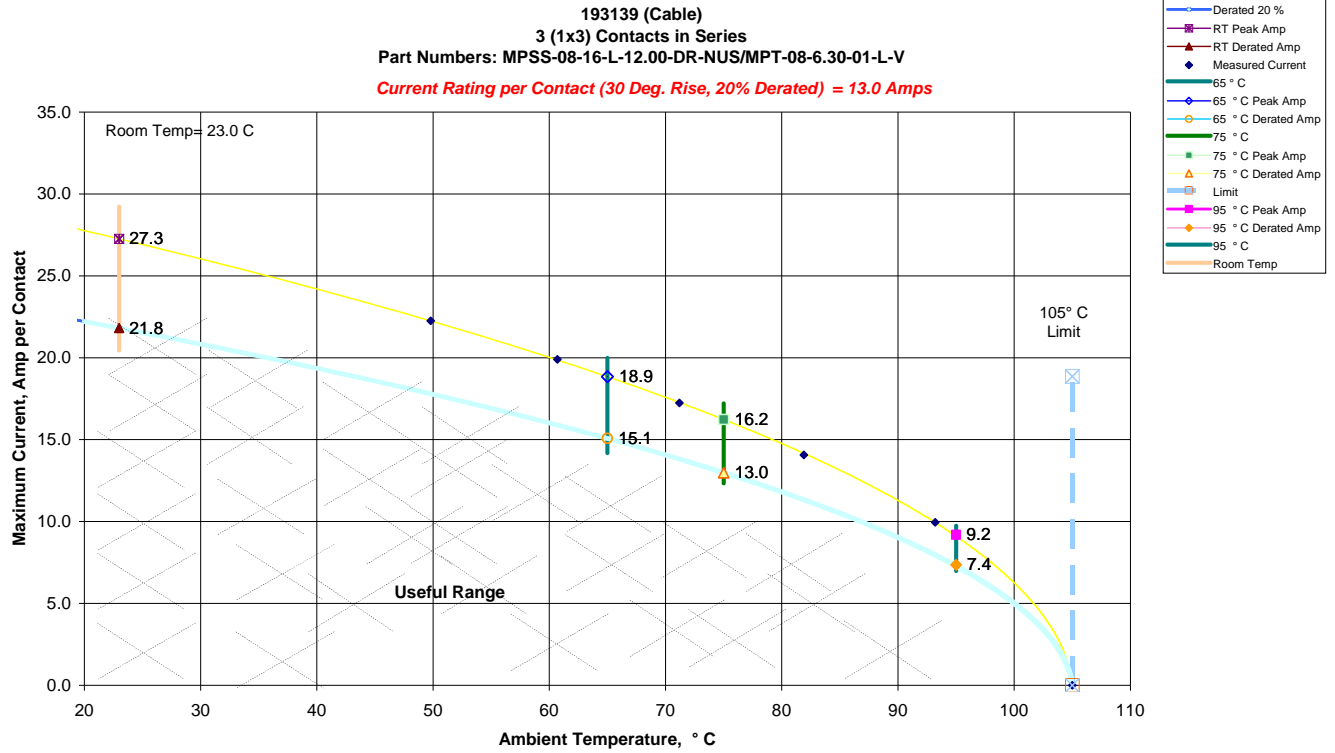
### TEMPERATURE RISE DATA TWO CONTACTS ENERGIZED (Degrees Celsius above ambient)

TEST CURRENT AMPS	10.59	14.96	18.34	21.18	23.67
Sample 4	11.5	22.4	33	43.7	54.8
Sample 5	10.7	21	31.4	41.8	52.4
Sample 6	10.5	20.6	29.9	39.1	49.1
Min	10.5	20.6	29.9	39.1	49.1
Max	11.5	22.4	33	43.7	54.8
Avg	10.9	21.33	31.43	41.53	52.1

✦ Indicates energized contacts

✦ Indicates thermocouple monitored, energized contacts



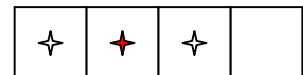


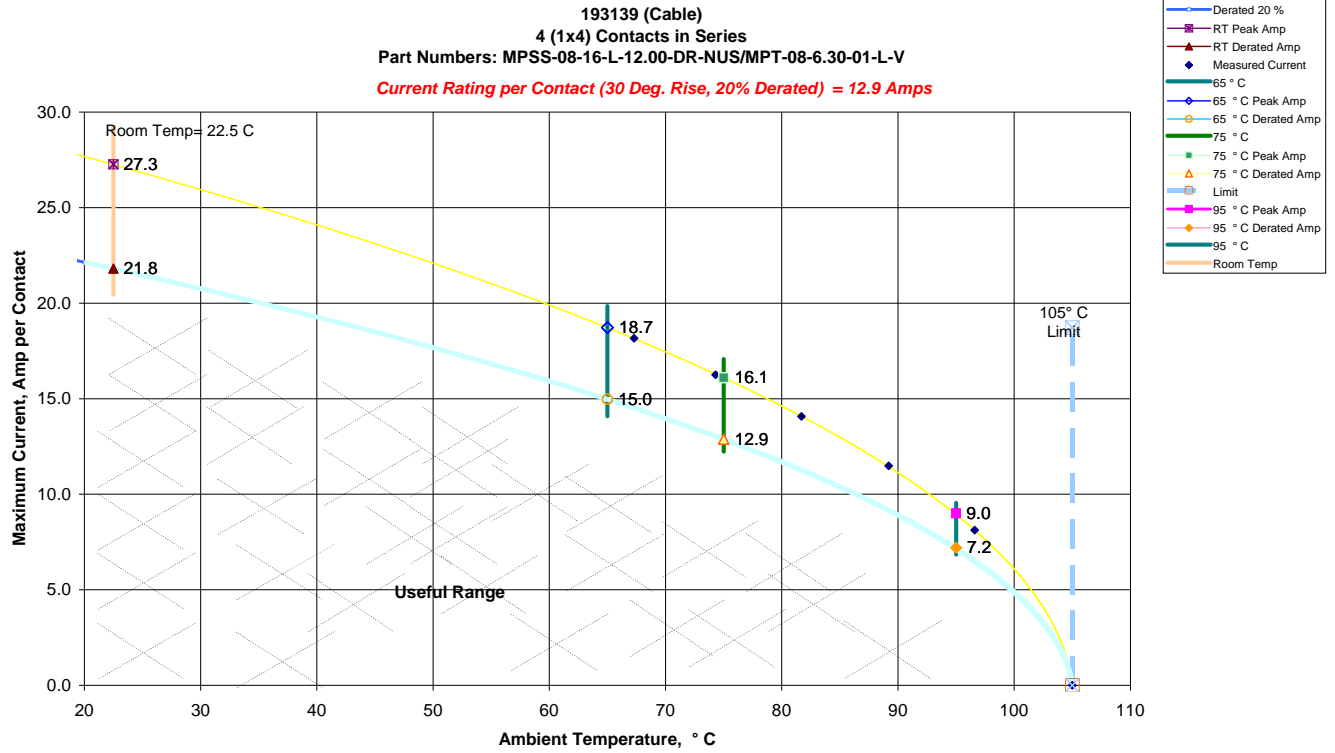
### TEMPERATURE RISE DATA THREE CONTACTS ENERGIZED (Degrees Celsius above ambient)

TEST CURRENT AMPS	10.59	14.96	18.34	21.18	23.67
Sample 7	11.4	22.2	31.6	40.7	50.2
Sample 8	13	25.9	38.4	50.6	63.1
Sample 9	10.9	21.1	31.4	41.7	52.4
Min	10.9	21.1	31.4	40.7	50.2
Max	13	25.9	38.4	50.6	63.1
Avg	11.77	23.07	33.8	44.33	55.23

✦ Indicates energized contacts

✦ Indicates thermocouple monitored, energized contacts



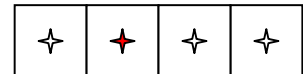


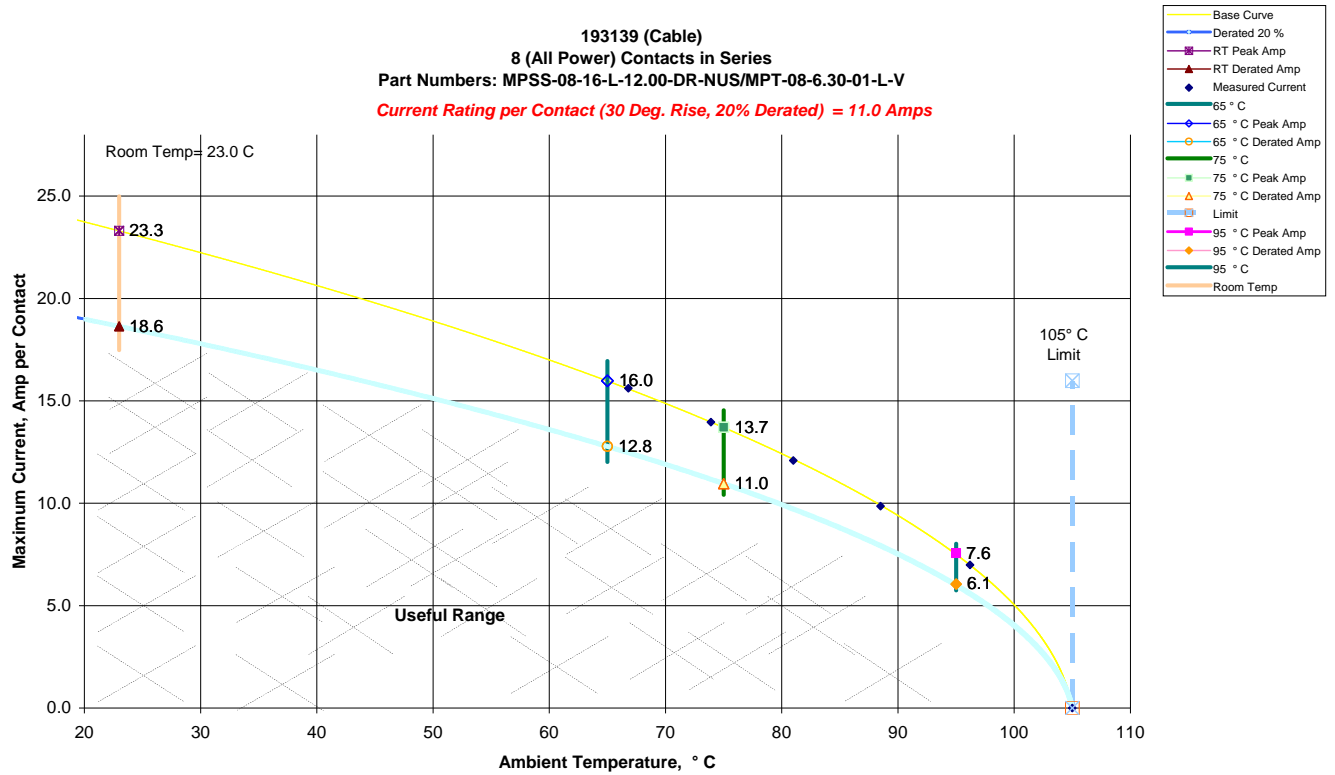
### TEMPERATURE RISE DATA FOUR CONTACTS ENERGIZED (Degrees Celsius above ambient)

TEST CURRENT AMPS	8.12	11.49	14.07	16.25	18.16
Sample 10	8.1	15	22.2	29.7	36.1
Sample 11	8.4	16	23.7	30.9	38.3
Sample 12	8.6	16.3	24	31.4	38.7
Min	8.1	15	22.2	29.7	36.1
Max	8.6	16.3	24	31.4	38.7
Avg	8.37	15.77	23.3	30.67	37.7

✦ Indicates energized contacts

✦ Indicates thermocouple monitored, energized contacts

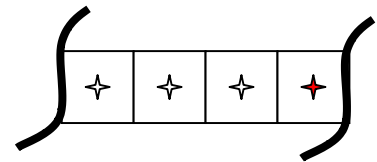


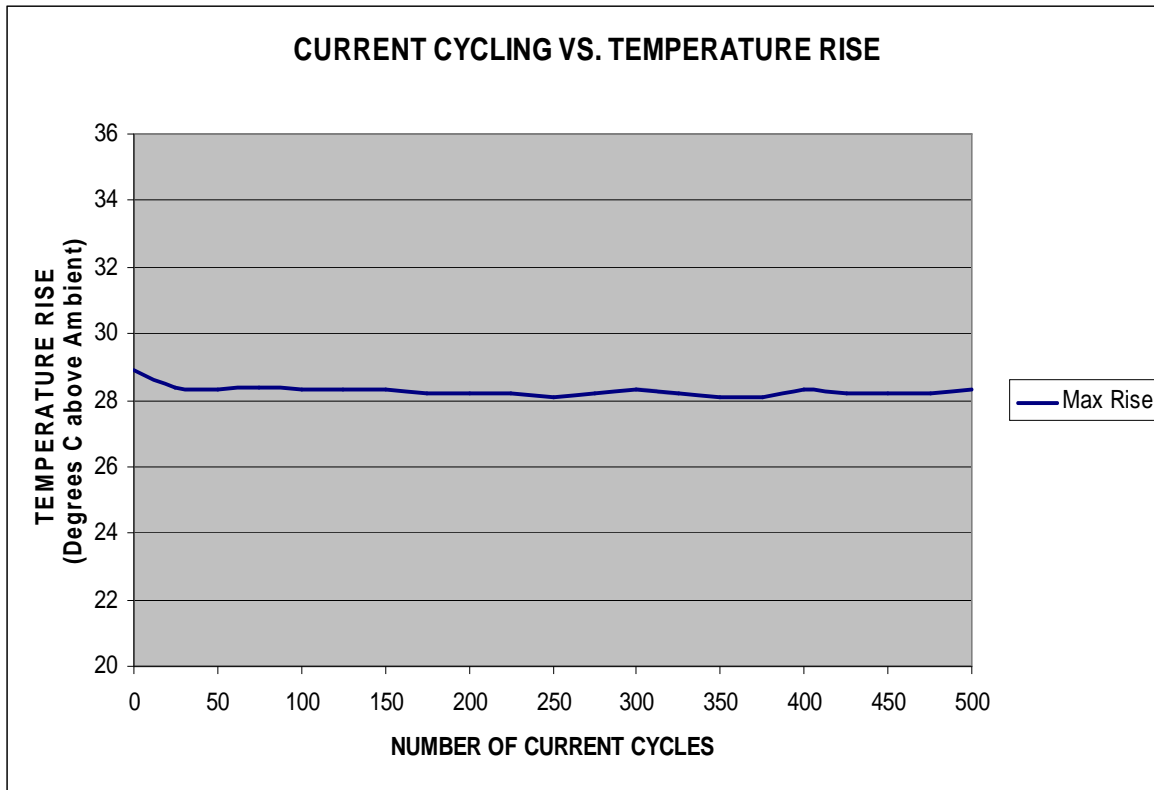


### TEMPERATURE RISE DATA ALL CONTACTS ENERGIZED (Degrees Celsius above ambient)

TEST CURRENT AMPS	6.99	9.86	12.09	13.96	15.61
Sample 13	8.4	16.1	23.6	30.8	37.7
Sample 14	9.2	16.4	23.7	30.7	37.8
Sample 15	9	17	24.6	31.8	39.2
Min	8.4	16.1	23.6	30.7	37.7
Max	9.2	17	24.6	31.8	39.2
Avg	8.87	16.5	23.97	31.1	38.23

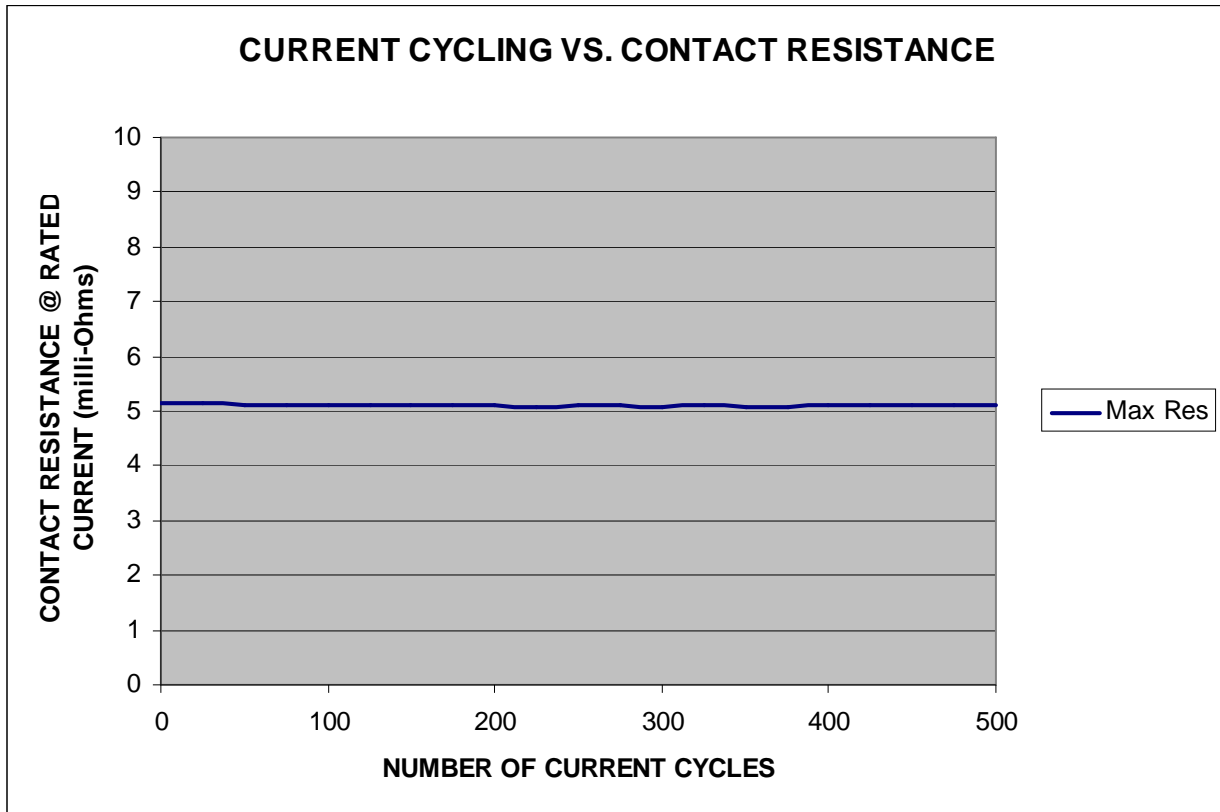
- ✦ Indicates energized contacts
- ✦ Indicates thermocouple monitored, energized contacts





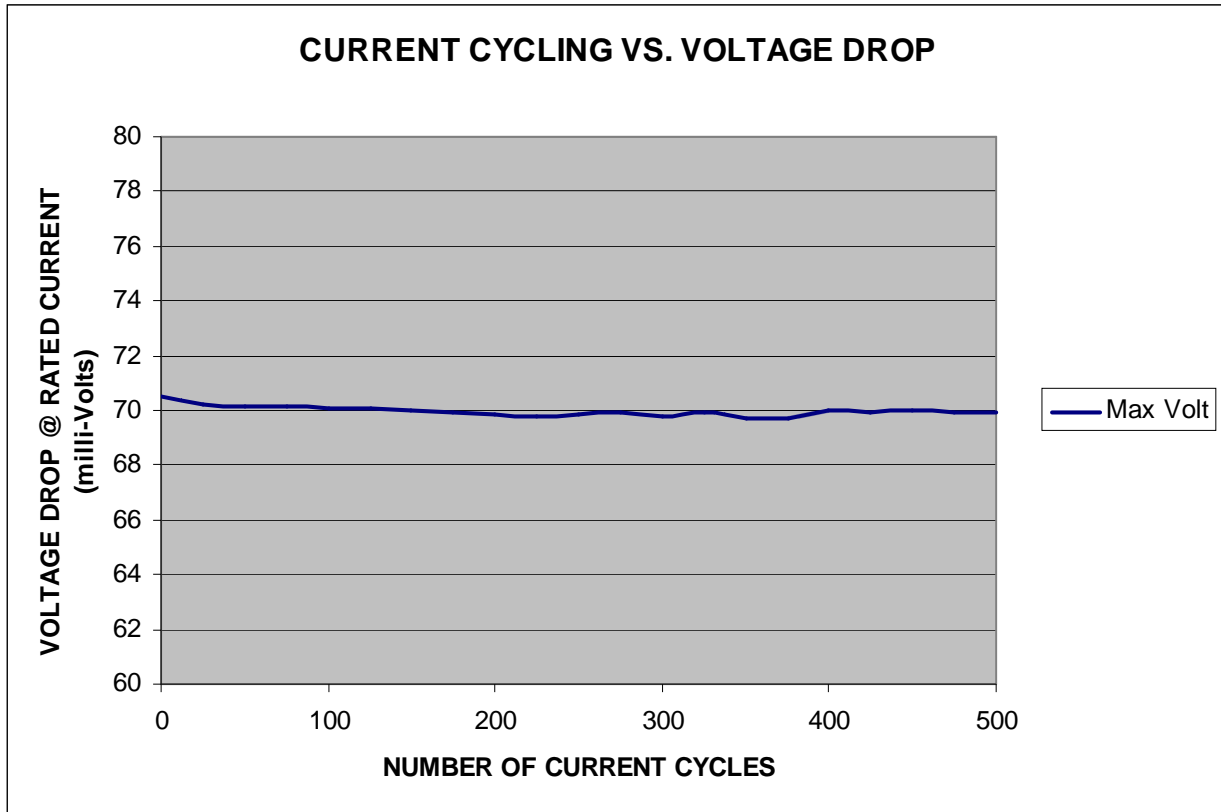
**TEMPERATURE RISE DATA  
ALL CONTACTS ENERGIZED  
(Degrees Celsius above ambient)**

	<b>INITIAL</b>	<b>50 CYCLES</b>	<b>100 CYCLES</b>	<b>200 CYCLES</b>	<b>500 CYCLES</b>
<b>Min</b>	24	23.2	22.8	22.4	22
<b>Max</b>	28.9	28.3	28.3	28.2	28.3
<b>Avg</b>	26.7	26.3	26.3	26.1	26



**CONTACT RESISTANCE DATA  
ALL CONTACTS ENERGIZED  
(mΩ)**

	INITIAL	50 CYCLES	100 CYCLES	200 CYCLES	500 CYCLES
<b>Min</b>	4.86	4.86	4.86	4.85	4.86
<b>Max</b>	5.15	5.12	5.11	5.1	5.1
<b>Avg</b>	5.02	5.01	5.01	4.99	5



**VOLTAGE DROP DATA  
ALL CONTACTS ENERGIZED  
(MV)**

	INITIAL	50 CYCLES	100 CYCLES	200 CYCLES	500 CYCLES
<b>Min</b>	66.54	66.54	66.58	66.42	66.61
<b>Max</b>	70.5	70.14	70.06	69.85	69.92
<b>Avg</b>	68.76	68.59	68.57	68.38	68.48

**EQUIPMENT AND CALIBRATION SCHEDULES****Equipment #:** MO-10**Description:** Model 2750 Multimeter/Switch System (Integra Series)**Manufacturer:** Keithly**Model:** 2750**Serial #:** 1215161**Accuracy:** See Manual

... Last Cal:10/18/2011, Next Cal: 10/18/2012

**Equipment #:** MO-09**Description:** Model 2750 Multimeter/Switch System (Integra Series)**Manufacturer:** Keithly**Model:** 2750**Serial #:** WDC-874817**Accuracy:** See Manual

... Last Cal: 9/30/2011, Next Cal: 9/30/2012

**Equipment #:** PS-09**Description:** 60V 50 A DC Power Supply-AutoRanging SO**Manufacturer:** Hewlett Packard/Agilent**Model:** HP 6032A**Serial #:** US38322853**Accuracy:** See Manual**Equipment #:** PS-04**Description:** 60V 50 A DC Power Supply-AutoRanging SO**Manufacturer:** Hewlett Packard/Agilent**Model:** AT-6032A**Serial #:** MY41001186**Accuracy:** See Manual**Equipment #:** RS-01**Description:** Shunt**Manufacturer:** EMPRO**Model:** HA5050**Serial #:** HA5050**Accuracy:**  $\pm 0.25\%$  RDG

... Last Cal: 5/30/2012 Next Cal: 5/30/2013

**Equipment #:** RS-04**Description:** Shunt**Manufacturer:** EMPRO**Model:** HA5050**Serial #:** HA5050**Accuracy:**  $\pm 0.25\%$  RDG

... Last Cal: 5/30/2012, Next Cal: 5/30/2013



**POWER INTEGRITY TEST  
REPORT**

**193139**

**INITIAL RELEASE**

**Equipment #:** TC111307-(TCS-005-048)

**Description:** Calibrated Thermocouples

**Manufacturer:** Samtec, Inc.

**Model:**

**Serial #:**

**Accuracy:**

... Last Cal:5/16/2012, Next Cal: 5/16/2013